



Sheet <u>1</u> of <u>1</u>

Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 09712-032001

Application No. 09/305,808

Information Disclosure Statement by Applicant (Use several sheets if necessary) Applicant
William A. Shull et al.

Filing Date
April 28, 1999

Group Art Unit

(37 CFR §1.98(b))

			U.S. Pate	nt Documents			
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EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary

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William A. Shull et al. FILING DATE April 28, 1999

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